

FACULTY OF ELECTRICAL  
ENGINEERING**SUBJECT CARD**

Name in Polish: **Komputerowe zarządzanie systemami pomiarowymi**  
 Name in English: **Measurement systems management**  
 Main field of study (if applicable): **Electrical Engineering**  
 Specialization (if applicable): **Industrial Electrical Engineering**  
 Level and form of studies: **2nd level, part-time**  
 Kind of subject: **optional**  
 Subject code: **ELR043367**  
 Group of courses: **NO**

	Lecture	Classes	Laboratory	Project	Seminar
Number of hours of organized classes in University (ZZU):	22		11		
Number of hours of total student workload (CNPS):	54		27		
Form of crediting:	examination		crediting with grade		
For group of courses mark (X) final course:					
Number of ECTS points:	2		1		
including number of ECTS points for practical (P) classes :			1		
including number of ECTS points for direct teacher-student contact (BK) classes:	1.40		0.70		

**PREREQUISITES RELATING TO KNOWLEDGE, SKILLS AND OTHER COMPETENCES**

1. He can write C/C++ program  
He is able to do basic measurements of electrical devices using analog and digital oscilloscope. Can set on the basis of
2. measurements of nonlinear characteristics of the elements. Able to present the results in the form of numerical tables and graphics to make their interpretations and draw conclusions
3. He knows the concepts of programming in C / C + +
4. He has a basic knowledge of the measurement technique.  
He has a basic knowledge of metrology and measurement units, knows basic metrological characteristics of measuring
5. instruments, are knowledgeable about the design of measurement known calculation methods used in developing the measurement results

**SUBJECT OBJECTIVES**

- C1. Acquisition of knowledge in the field of architecture test and measurement systems, in particular the underlying hardware and software systems in high-level languages
- C2. Understanding the methodology for designing a control and measurement systems.
- C3. Learning how the practical implementation of measurement systems computer managed by an integrated software environment and includes standard interfaces and measuring instruments
- C4. Acquisition and consolidation of social skills including emotional intelligence skills involving the cooperation of a group of students with a view to effective problem solving. Responsibility, honesty and fairness in the procedure observance force in academia and society

**SUBJECT EDUCATIONAL EFFECTS***relating to knowledge:*

- PEK\_W01 He has knowledge of the architecture of test and measurement systems  
 PEK\_W02 He has extensive knowledge in the construction of hardware layer and system programming in high level languages.  
 PEK\_W03 He or she knows and understand the design methodology of control and measurement systems.

*relating to skills:*

- PEK\_U01 He has skills practical implementation of measurement systems computer managed by an integrated development environment dedicated  
 PEK\_U02 He or she can design measurement test stand with standard interfaces and devices  
 PEK\_U03 He has skills to design virtual instruments

*relating to social competences:*

- PEK\_K01 He or she is aware of their own responsibility for their work and a willingness to comply with the principles of teamwork. He searches information and its critical analysis, properly identifies and resolves the dilemmas of working in the profession

## PROGRAMME CONTENT

Form of classes - lecture		Number of hours:
Lec 1	Metrology and Measurement Systems Computer elementary functions. The structure and organization of measurement systems	2
Lec 2	Structure and operation of digital measuring instruments - multimeter, oscilloscope, Logic analyzer	2
Lec 3	Direct Digital Synthesis Generator and arbitrary generator	2
Lec 4	Serial Interfaces in Measurement systems	2
Lec 5	USB and FireWire ( IEEE 1394)	2
Lec 6	GPIO (IEEE-488) Interface	2
Lec 7	Wireless network in measurement systems	2
Lec 8	VME, VXI and PXI Standard	2
Lec 9	Software of measurement systems - an integrated software environment, discussion of the workings of graphical interfaces. Programming measurement systems using a dedicated library VISA and SCPI commands	2
Lec 10	Data acquisition board - block diagram and programming	2
Lec 11	Sensors and signal transducers, Distributed measurement systems	2
Total hours:		<b>22</b>

Form of classes - laboratory		Number of hours:
Lab 1	Presentation of the safety rules and principles of assessment laboratory. Presentation of laboratory	1
Lab 2	Introduction to the programming environment, VISA and window that allows you to send and receive messages from the measuring devices. Construction of the device ID. Grammar and statement SCPI commands	2
Lab 3	Introduction to the SCPI command tree of oscilloscope and generator or power supply and DMM. Control the instruments using a instrument driver or Direct I / O Command	2
Lab 4	Implementation of the task - automatic determination of filter characteristics or u-i characteristics	2
Lab 5	Programming the daq board. Using Daq assistant for data acquisition from the analog-to-digital converter	2
Lab 6	Programming a multifunction dac board: Use counters, digital inputs and outputs and analog outputs	2
Total hours:		<b>11</b>

## TEACHING TOOLS USED

- N1. Traditional Lecture with audio-visual techniques  
 N2. Laboratory run in the traditional manner of exercises + student groups, a report

## EVALUATION OF SUBJECT EDUCATIONAL EFFECTS ACHIEVEMENT

Evaluation <i>F - forming (during semester) P - concluding (at semester end)</i>	Educational effect number	Way of evaluating educational effect achievement
F1(W)	PEK_W01 PEK_W02 PEK_W03	Exam
P(W)	P=F1	
F1(L)	PEK_U01 PEK_U02 PEK_U03 PEK_K01	Average assessment of implementation of tasks during laboratory classes
P(L)	P=F1	

<b>PRIMARY AND SECONDARY LITERATURE</b>
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<b>PRIMARY LITERATURE:</b>
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| <ul style="list-style-type: none"><li>[1] Winiecki W., Organizacja komputerowych systemów pomiarowych, Oficyna wydawnicza Politechniki Warszawskiej, Warszawa 1997.</li><li>[2] Mielczarek W.- Urządzenia pomiarowe i systemy kompatybilne ze standardem SCPI – Helion 1999</li><li>[3] Nawrocki W.- Rozproszone systemy pomiarowe- WKŁ 2006</li><li>[4] Świsulski D- Komputerowa technika pomiarowa. Oprogramowanie wirtualnych przyrządów pomiarowych w LabVIEW – PAK 2005</li><li>[5] Świsulski D- Komputerowa technika pomiarowa w przykładach – PAK 2002</li><li>[6] Tłaczała W.: Środowisko LabVIEW w eksperymencie wspomagany komputerowo. WNT, Warszawa 2002</li></ul> |
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<b>SECONDARY LITERATURE:</b>
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| <ul style="list-style-type: none"><li>[1] Winiecki W., Nowak J., Stanik S.: Graficzne zintegrowane środowiska programowania do projektowania komputerowych systemów pomiarowo-kontrolnych. Wyd. Mikom, Warszawa 2001.</li><li>[2] Bogusz J.: Lokalne interfejsy szeregowo w systemach cyfrowych – Wydawnictwo BTC, Warszawa 2004</li><li>[3] Mielczarek W. Szeregowe interfejsy cyfrowe, Helion, Gliwice 1993;</li><li>[4] Mielczarek W -USB : uniwersalny interfejs szeregowy, Helion, Gliwice 2005.</li><li>[5] Mielczarek W - Szeregowy interfejs cyfrowy FireWire : standardy IEEE 1394,., Wydawnictwo Politechnik Śląskiej, Gliwice 2010</li><li>[6] Daniluk A.- USB : praktyczne programowanie z Windows API w C++ Helion, Gliwice 2009</li></ul> |
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<b>SUBJECT SUPERVISOR</b>
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MATRIX OF CORRELATION BETWEEN EDUCATIONAL EFFECTS FOR SUBJECT  
**ELR043367 - Measurement systems management**  
AND EDUCATIONAL EFFECTS FOR MAIN FIELD OF STUDY **Electrical Engineering**  
AND SPECIALIZATION **Industrial Electrical Engineering**

Subject educational effect	Correlation between subject educational effect and educational effects defined for main field of study and specialization (if applicable)	Subject objectives	Programme content	Teaching tool number
PEK_W01	S2ETP_W11	C.1 C.2 C.4	Lec1 Lec2 Lec3 Lec4 Lec5 Lec6 Lec7 Lec8 Lec9 Lec10 Lec11	N.1
PEK_W02	S2ETP_W11	C.1 C.2 C.4	Lec1 Lec2 Lec3 Lec4 Lec5 Lec6 Lec7 Lec8 Lec9 Lec10 Lec11	N.1
PEK_W03	S2ETP_W11	C.1 C.2 C.4	Lec1 Lec2 Lec3 Lec4 Lec5 Lec6 Lec7 Lec8 Lec9 Lec10 Lec11	N.1
PEK_U01	S2ETP_U09	C.3 C.4	Lab1 Lab2 Lab3 Lab4 Lab5 Lab6	N.2
PEK_U02	S2ETP_U09	C.3 C.4	Lab1 Lab2 Lab3 Lab4 Lab5 Lab6	N.2
PEK_U03	S2ETP_U09	C.3 C.4	Lab1 Lab2 Lab3 Lab4 Lab5 Lab6	N.2
PEK_K01	K2ETK_K02	C.4	Lec1 Lec2 Lec3 Lec4 Lec5 Lec6 Lec7 Lec8 Lec9 Lec10 Lec11 Lab1 Lab2 Lab3 Lab4 Lab5 Lab6	N.1 N.2